

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 09/944,323 | Applicant(s)/Patent Under Reexamination JAMES ET AL | |
| | Examiner Alexander O. Williams | Art Unit 2826 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| | A | US-2002/0186549 A1 | 12-2002 | Bolken, Todd O. | 361/737 |
| | B | US-2003/0178748 A1 | 09-2003 | Bolken et al. | 264/272.17 |
| | C | US-2003/0034568 A1 | 02-2003 | Chai et al. | 257/788 |
| | D | US-6,626,656 | 09-2003 | Thummel, Steven G. | 425/116 |
| | E | US-5,757,067 | 05-1998 | Inaba, Takehito | 257/666 |
| | F | US-5,853,771 | 12-1998 | Matsumoto, Jirou | 425/116 |
| | G | US-5,776,512 | 07-1998 | Weber, Patrick O. | 425/116 |
| | H | US-5,623,163 | 04-1997 | Izumi, Atsuhiko | 257/667 |
| | I | US-5,550,711 | 08-1996 | Burns et al. | 361/728 |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.